

CE EMC

TEST REPORT

For

Compact Board

Model: PCM-8150

Trade Name: AAEON

Issued to

AAEON Technology Inc. 5F, No. 135, Lane 235, Pao Chiao Rd., Hsin-Tien City, Taipei, Taiwan, R.O.C.

Issued by

Compliance Certification Services Inc. Hsintien Lab.



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1 TEST RESULT CERTIFICATION

Applicant: AAEON Technology Inc.

5F, No. 135, Lane 235, Pao Chiao Rd., Hsin-Tien City,

Date of Issue: January 18, 2005

Taipei, Taiwan, R.O.C.

Manufacturer: AAEON Technology Inc.

5F, No. 135, Lane 235, Pao Chiao Rd., Hsin-Tien City,

Taipei, Taiwan, R.O.C.

Equipment Under Test: Compact Board

Trade Name: AAEON

Model: PCM-8150

Detailed EUT Description: See Item 2 of this report

Date of Test: January 10, 2005 ~ January 12, 2005

Applicable Standard	Class/Limit/Criterion	Test Result		
EN 55022: 1998 + A1: 2000 + A2: 2003	Class B	No non-compliance noted		
EN 61000-3-2: 2000	Class D	N/A		
EN 61000-3-3: 1995 + A1: 2001	Limit	No non-compliance noted		
EN 55024:1998 + A1: 2001 + A2: 2003, include	ling			
IEC 61000-4-2: 1995+A1: 1998+ A2: 2000	Criterion B	No non-compliance noted		
IEC 61000-4-3: 1995+A1: 1998+ A2: 2000	Criterion A	No non-compliance noted		
IEC 61000-4-4: 1995+A1: 2000	Criterion B	No non-compliance noted		
IEC 61000-4-5: 1995+A1: 2000	Criterion B	No non-compliance noted		
IEC 61000-4-6: 1996+A1: 2000	Criterion A	No non-compliance noted		
IEC 61000-4-8: 1993+A1: 2000	Criterion A	N/A		
IEC 61000-4-11: 1994+A1: 2000	Criterion B/C/C	No non-compliance noted		
Deviation from Applicable Standard				
At the customers' request, we adopt the above standards.				

The above equipment was tested by Compliance Certification Services Inc. for compliance with the requirements set forth in the EMC Directive 89/336/EMC and the technical standards mentioned above. The results of testing in this report apply only to the product/system, which was tested. Other similar equipment will not necessarily produce the same results due to production tolerance and measurement uncertainties.

Approved by: Reviewed by:

David Wang

Manager of Hsintien Laboratory

Compliance Certification Services Inc.

Vince Chiang

Section Manager of Hsintien Laboratory

Compliance Certification Services Inc.

2 EUT DESCRIPTION

Product	Compact Board
Trade Name	AAEON
Model	PCM-8150
Housing Type	N/A
EUT Power Rating	3.3VDC / ±5VDC / ±12VDC from Host PC
AC Power During Test	230VAC / 50Hz to Host PC Power Supply
Power Supply Manufacturer	Enhance
Power Supply Model Number	P1G-6300P
AC Power Cord Type	Unshielded, 1.8m (Detachable) to Host PC Power Supply
OSC/Clock Frequencies	32.768kHz; 14.318MHz; 25MHz

I/O PORT OF EUT

I/O PORT TYPE	Q'TY	TESTED WITH
1). PIO Port	1	1
2). SIO Port	4	4
3). PS/2 Keyboard Port	1	1
4). PS/2 Mouse Port	1	1
5). Video-Out Port (VGA)	1	1
6). Audio In Port	1	1
7). Microphone Port	1	1
8). Earphone Port	1	1
9). LAN Port	1	1
10). USB Port	4	4

Note: Client consigns only one model sample (Model Number is PCM-8150) to test.

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3 TEST METHODOLOGY

3.1 EUT SYSTEM OPERATION

- 1. Windows 2000 boots system.
- 2. Run Emctest.exe to activate all peripherals and display "H" pattern on the screen.

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- 3. Run Winemc.exe then select (E:/ & F:/ & G:/ & H:/)" to test USB 2.0 HDD.
- 4. Run Media player.exe to play music.
- 5. Press the start menu, select executive and type ping 192.168.1.100 –t (EUT), ping 192.168.1.10 –t (Server Notebook).

Note: Test program is self-repeating throughout the test.

3.2 DECISION OF FINAL TEST MODE

1. The following test mode(s) were scanned during the preliminary test:

Mode:

1. NORMAL MODE

2. After the preliminary scan, the following test mode was found to produce the highest emission level.

Conduction: Mode 1

Radiation: Mode 1

Then, the EUT configuration and cable configuration of the above highest emission mode was chosen for all final test items.

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4 SETUP OF EQUIPMENT UNDER TEST

Setup Diagram

See test photographs attached in Appendix I for the actual connections between EUT and support equipment.

Support Equipment

EUT Devices:

No	Equipment	Model #	Serial #	FCC ID / BSMI ID	Trade Name
1.	HDD (40GB)	VAM5JJ0	N/A	N/A	Maxtor
2.	Power supply (300Watts)	P1G-6300P	N/A	N/A	Enhance
3.	CPU (1GHz)	C3	N/A	N/A	VIA
4.	SDRAM (512MB)	DDR 400	N/A	N/A	SYNNEX

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Peripherals Devices:

No	Equipment	Model	Serial No.	FCC ID / BSMI ID	Trade Name	Data Cable	Power Cord
1.	USB 2.0 HDD	F12-UF	N/A	BSMI ID: 4912A002	TeraSyS	Shielded, 1.8m	N/A
2.	USB 2.0 HDD	F12-U	N/A	BSMI ID: 4912A002	TeraSyS	Shielded, 1.8m	N/A
3.	USB 2.0 HDD	F12-UF	N/A	BSMI ID: 4912A002	TeraSyS	Shielded, 1.8m	N/A
4.	USB 2.0 HDD	F12-U	N/A	BSMI ID: 4912A002	TeraSyS	Shielded, 1.8m	N/A
5.	PS/2 Mouse	M071KC	443029453	DoC BSMI: R41108	DELL	Shielded, 1.8m	N/A
6.	PS/2 Keyboard	SK-8110	N/A	DoC BSMI: T3A002	DELL	Shielded, 1.8m	N/A
7.	Player	RQ-L112T	N/A	BSMI ID: 3913A162	Panasonic	Unshielded, 2.0m	N/A
8.	Ear. / Mic.	MSB301	N/A	N/A	e-Sense	Unshielded, 2.0m	N/A
9.	Printer	C60	N/A	BSMI ID: 3902E006	EPSON	Shielded, 1.8m	Unshielded, 1.8m
10.	Modem	1414	N/A	IFAXDM1414	ACEEX	Shielded, 1.1m	Unshielded, 1.8m
11.	Modem	5JEG4033MKO	N/A	5RJTAI-35500-M5-E	TOP- SOLUTION	Shielded, 1.1m	Unshielded, 1.8m
12.	Monitor	710V	GS17H9NXA05 869X	DoC BSMI: R33475	SAMSUNG	Shielded, 1.8m with two cores	Unshielded, 1.8m
13.	Modem	5JEG4033MKO	N/A	5RJTAI-35500-M5-E	TOP- SOLUTION	Shielded, 1.1m	Unshielded, 1.8m
14.	Modem	5JEG4033MKO	N/A	5RJTAI-35500-M5-E	TOP- SOLUTION	Shielded, 1.1m	Unshielded, 1.8m
15.	Server Notebook	2659-FT1	AK-VHXOH 02/10 C	ANOPSIWLIV	IBM	Unshielded, 20m	Unshielded, 1.8m

Note: All the above equipment/cables were placed in worse case positions to maximize emission signals during emission test.

Grounding: Grounding was in accordance with the manufacturer's requirements and conditions for the intended use.

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5 FACILITIES AND ACCREDITATIONS

5.1 FACILITIES

All measurement facilities used to collect the measurement data are located at CCS Taiwan Hsintien Lab at No. 165, Chunghsen Road, Hsintien City, Taipei Hsien, Taiwan.

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The measurement facilities are constructed in conformance with the requirements of CISPR 16-1, ANSI C63.4 and other equivalent standards.

5.2 LABORATORY ACCREDITATIONS AND LISTINGS

The test facilities used to perform Electromagnetic compatibility tests are registered or accredited by the organizations listed in the following table which includes the recognized scope specifically.

Country	Agency	Scope of Accreditation	Logo
USA	A2LA	CFR 47, FCC Part 15/18 using ANSI 63.4; AS/NZS 3548; VCCI V3; CNS 13438; CNS 13439; CNS 13783; CNS 14115; CISPR 11/EN 55011; CISPR 14-1/EN 55014-1; CISPR 15/EN 55015; CISPR 22/EN 55022; EN 50081-1/EN 61000-6-3; EN 50082-1/EN 61000-6-4; IEC/EN 61000-4-2, IEC/EN 61000-4-3, IEC/EN 61000-4-4, IEC/EN 61000-4-5, IEC/EN 61000-3-2, IEC/EN 61000-3-3; CISPR 24/EN 55024; CISPR 14-2/EN 55014-2; EN 50081-2/EN 61000-6-1; EN 50082-2/EN 61000-6-2.	ACCREDITED
USA	FCC	3/10 meter Open Area Test Sites to perform FCC Part 15/18 measurements	FC 250366
Japan	VCCI	3/10 meter Open Area Test Sites and Line Conducted Test Room to perform conducted/radiated measurements	VCCI R-1434/1630~4 C-1511/1882
Norway	NEMKO	EN 50081-1/2, EN 50082-1/2, IEC 61000-6-1/2/3/4, EN 50091-2, EN 50130-4, EN 55011, EN 55013, EN 55014-1/2, EN 55015, EN 55022, EN 55024, EN 61000-3-2/3, EN 61326-1, IEC 61000-4-2/3/4/5/6/8/11, Cispr 16-1/2/3/4	N ELA 103
Taiwan	CNLA	47 CFR FCC Part 15 Subpart B, EN 61000-3-2, EN 61000-3-3, CNS 13439, CNS 13783-1, CNS 13438, AS/NZS 3548, VCCI, CNS 13022-1/2/3, EN 55022, EN 55013, EN 55014-1, EN 61000-4-2/3/4/5/6/8/11, ENV 50204, ENV 50141, ENV 50142	1108 ILAG MRA
Taiwan	BSMI	CNS 13438, CNS 13783-1, CNS 13439	SL2-IN-E-0005 SL2-A1-E-0005 SL2-R1-E-0005 SL2-R2-E-0005

Note: No part of this report may be used to claim or imply product endorsement by CNLA, A2LA or other government agency.

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6 INSTRUMENT AND CALIBRATION

6.1 MEASURING INSTRUMENT CALIBRATION

The measuring equipment utilized to perform the tests documented in this report has been calibrated once a year or in accordance with the manufacturer's recommendations, and is traceable to recognized national standards.

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6.2 TEST AND MEASUREMENT EQUIPMENT

The following list contains measurement equipment used for testing. The equipment conforms to the requirement of CISPR 16-1, ANSI C63.2 and. other required standards.

Calibration of all test and measurement, including any accessories that may effect such calibration, is checked frequently to ensure the accuracy. Adjustments are made and correction factors are applied in accordance with the instructions contained in the respective manual.

Equipment Used for Emission Measurement

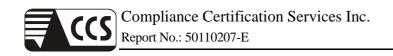
Open Area Test Site # J						
EQUIPMENT	MFR	MODEL	SERIAL NUMBER	CAL. DUE		
SITE NSA	CCS	J Site	N/A	09/18/2005		
MEASURE RECEIVER	SCHAFFNER	SCR3501	330	06/27/2005		
SPECTRUM ANALYZER	ADVANTEST	R3132	120900003	No Calibration Required		
ANTENNA	SCHAFFNER	CBL 6112B	2800	09/25/2005		
PRE- AMPLIFIER	SCHAFFNER	CPA9231A	3629	10/08/2005		
CABLE	BELDEN	9913	N-TYPE #J1	10/08/2005		
ATTENUATOR	MCL	UNAT-6	AT06-8	12/03/2005		
THERMO- HYGRO METER	TFA	N/A	NO.3	11/09/2005		
DECOUPLING NETWORK	FCC	F-201-DCN-5-6MM	22、24	09/07/2005		

Note: The measurement uncertainty is less than +/- 3.36dB, which is evaluated as per the NAMAS NIS 81 and CISPR/A/291/CDV.

Conducted Emission Test Site # A						
EQUIPMENT	MFR	MODEL	SERIAL NUMBER	CAL. DUE		
TEST RECEIVER	R&S	ESHS20	840455/006	03/07/2005		
LISN (EUT)	SCHWARZBECK	NSLK 8127	8127382	01/03/2006		
LISN	SOLAR	8012-50-R-24-BNC	8305114	01/03/2006		
BNC CABLE	MIYAZAKI	5D-FB	BNC A1	01/30/2005		
THERMO- HYGRO METER	ТОР	HA-202	9303-1	03/24/2005		
4-Wire ISN	R&S	ENY41	100006	07/01/2005		
2-Wire ISN	R&S	ENY22	100020	07/01/2005		

Note: The measurement uncertainty is less than +/- 2.83dB, which is evaluated as per the NAMAS NIS 81 and CISPR/A/291/CDV.

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Power Harmonic & Voltage Fluctuation/Flicker Test Site (EN 61000-3-2&-3-3)						
Manufacturer/Type Model No. Serial No. Cal. Du						
Schaffner / Signal Conditioning Unit	CCN 1000-1	72122	12/05/2005			
Schaffner / 5KVA AC Power Source	NSG 1007	55131	No Calibration Required			
Protronix / Digital Power Meter	1201	201091	08/31/2005			

Equipment Used for Immunity Measurement

ESD Test Site (EN 61000-4-2)						
Manufacturer/Type	Model No.	Serial No.	Cal. Due			
Schaffner / ESD Simulator	NSG 438	129	04/21/2005			
Stockburger / Aneroid Barometer	Barometer	9303	03/30/2005			
TOP / Thermo-Hygro meter	HA-202	9303-1	03/24/2005			

Radiated Electromagnetic Field Immunity Test Site (EN 61000-4-3)						
Manufacturer/Type	Model No.	Serial No.	Cal. Due			
Calibration of Field	Chamber#RS	RS3H-6 / RS3V-6	07/02/2005			
Agilent / Signal Generator	E4421B	MY43350597	05/30/2005			
AR / Electric Field Probe	FP6001	305657	03/17/2005			
Boonton / RF Voltmeter	9200B	328001AE	02/18/2005			
BNC / Function Generator	625	25451	02/18/2005			
AR / Amplifier	100W1000M1	17564	No Calibration Required			
Werlatone Inc. / Direction Coupler	C2630	4121	No Calibration Required			
Frankonia / Broadband Antenna	BTA-M	030001M	No Calibration Required			
TOP / Thermo-Hygro meter	HA-202	9303-2	03/24/2005			

Fast Transients/Burst Test Site (EN 61000-4-4)						
Manufacturer/Type	Model No.	Serial No.	Cal. Due			
Schaffner / EFT Generator	BEST EMC V2.3	200031A024SC				
Schaffner / Capacitive Clamp	N/A	N/A	No Calibration Required			

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Surge Immunity Test Site (EN 61000-4-5)					
Manufacturer/Type	Model No.	Model No. Serial No.			
Schaffner / Surger Generator	BEST EMC V2.3	200031A024SC	11/09/2005		
Schaffner / Signal and Data Lines Coupling Network	CDN118	19328	No Calibration Required		

	CS test (EN 61	1000-4-6)		
Manufacturer/Type	Model No.	Serial No.	Cal. Due	
Schaffner / RF Generator	NSG 2070-1	1061	08/02/2005	
Schaffner / CDN	CDN M316	19600	08/02/2005	
Schaffner / CDN	CDN M216	19294	08/02/2005	
Schaffner / EM Clamp	KEMZ 801	19227	03/02/2005	
Schaffner / CDN	CDN A800	17885	08/02/2005	
Schaffner / CDN	CDN T002	15881	01/30/2005	
FCC / CDN	FCC-801-T8-RJ45	04025	06/24/2005	
Schaffner / Attenuator	INA2070-1	2061	No Calibration Required	
FCC / CDN	FCC-801-T4-RJ45	04031	08/19/2005	

Power Frequency Magnetic Field Immunity test (EN 61000-4-8)						
Manufacturer/Type	Serial No.	Cal. Due				
Schaffner / Induction Coil Interface	INA 21141	6009	No Calibration Required			
Schaffner / 5KVA AC Power Source	NSG 1007	55131	No Calibration Required			
CHY/ TRMS Clamp Meter	932C	2K0900285	10/12/2005			
Sypris / Magnetic Field Meter	4080	0247	02/11/2005			

Voltage Dips/Short Interruption and Voltage Variation Immunity test (EN 61000-4-11)						
Manufacturer/Type	Model No.	Serial No. Cal. Due				
Schaffner / Dips/Interruption/Variations Tester	BEST EMC V2.3	200031A024SC	11/09/2005			
Protronix / Digital Power Meter	1201	201091	08/31/2005			

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7 LINE CONDUCTED & RADIATED EMISSION TEST

7.1 LIMIT

Maximum permissible level of Line Conducted Emission

FREQUENCY	Class A (dBuV)		Class B (dBuV)		
(MHz)	Quasi-peak Average		Quasi-peak	Average	
0.15 - 0.5	79	66	66 - 56	56 - 46	
0.50 - 5.0	73	73 60 56	56	46	
5.0 - 30.0	73	60	60	50	

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Note: The lower limit shall apply at the transition frequency.

<u>Maximum permissible level of Common Mode Conducted Emission</u> (Telecommunication Ports)

CLASS A

FREQUENCY	Voltage Limit (dBuV)		Current Limit (dBuA)		
(MHz)	Quasi-peak Average		Quasi-peak	Average	
0.15 - 0.5	97 – 87	84 - 74	53 – 43	40 – 30	
0.5 - 30.0	87	74	43	30	

CLASS B

FREQUENCY	Voltage Limit (dBuV)		Current Limit (dBuA)		
(MHz)	Quasi-peak Average		Quasi-peak	Average	
0.15 - 0.5	84 - 74	74 - 64	40 – 30	30 - 20	
0.5 - 30.0	74	64	30	20	

Note: The lower limit shall apply at the transition frequency.

Maximum permissible level of Radiated Emission measured at 10 meter

FREQUENCY	Class A (dBuV/m)	Class B (dBuV/m)		
(MHz)	Quasi-peak	Quasi-peak		
30 – 230	40	30		
230 - 1000	47	37		

Note: The lower limit shall apply at the transition frequency.

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7.2 TEST PROCEDURE OF LINE CONDUCTED EMISSION

Procedure of Preliminary Test

• The EUT was set up as per the test configuration to simulate typical usage per the user's manual. When the EUT is a tabletop system, a wooden table with a height of 0.8 meters is used and is placed on the ground plane as per EN 55022 (see Test Facility for the dimensions of the ground plane used). When the EUT is a floor-standing equipment, it is placed on the ground plane which has a 3-12 mm non-conductive covering to insulate the EUT from the ground plane.

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- Support equipment, if needed, was placed as per EN 55022.
- All I/O cables were positioned to simulate typical actual usage as per EN 55022.
- The test system with EUT received AC power, 230V/50Hz, through a Line Impedance Stabilization Network (LISN), which supplied power source and was grounded to the ground plane.
- All support equipment received power from a second LISN.
- The EUT test program was started. Emissions were measured on each current carrying line of the EUT using an EMI Test Receiver connected to the LISN powering the EUT.
- The Receiver scanned from 150kHz to 30MHz for emissions in each of the test modes.
- During the above scans, the emissions were maximized by cable manipulation.
- The test mode(s) described in Item 3.2 were scanned during the preliminary test.
- After the preliminary scan, we found the test mode described in Item 3.2 producing the highest emission level.
- The EUT configuration and cable configuration of the above highest emission level were recorded for reference of the final test.

Procedure of Final Test

- EUT and support equipment were set up on the test bench as per the configuration with highest emission level in the preliminary test.
- A scan was taken on both power lines, Line 1 and Line 2, recording at least the six highest emissions. Emission frequency and amplitude were recorded into a computer in which correction factors were used to calculate the emission level and compare reading to the applicable limit. If EUT emission level was less –2dB to the Average limit in Q.P. mode, then the emission signal was re-checked using an Average detector.
- The test data of the worst-case condition(s) was recorded.

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Data Sample:

Freq. MHz	Read Level dBuV	Factor dB	Level dBuV	Limit dBuV	Over Limit dB	Reading Type (P/Q/A)	Line (L1/L2)
x.xx	42.95	0.55	43.50	73	-29.5	Q	L1

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Freq. = Emission frequency in MHz

Read Level = Uncorrected Analyzer/Receiver reading Factor = Insertion loss of LISN + Cable Loss

Level = Read Level + Factor Limit = Limit stated in standard Over Limit = Reading in reference to limit

P = Peak Reading

Q = Quasi-peak Reading A = Average Reading

L1 = Hot side L2 = Neutral side

Calculation Formula

Over Limit (dB) = Level (dBuV) – Limit (dBuV)

7.3 TEST PROCEDURE OF COMMON MODE CONDUCTED EMISSION FOR TELECOMMUNICATION PORT

- Selecting ISN for unscreened cable or a current probe for screened cable to take measurement.
- The port of the EUT was connected to the remote side support equipment through the ISN/Current Probe and communication in normal condition.
- Making a overall range scan by using the test receiver controlled by controller and record at least six highest emissions for showing in the test report.
- Emission frequency and amplitude were recorded into a computer in which correction factors were used to calculate the emission level and compare reading to the applicable limit.
- In case of measuring on the screened cable, the current limit shall be applied, otherwise the voltage limit should be applied.
- The following test mode(s) were scanned during the preliminary test:

Mode(s):

1.	100Mbps
2.	10Mbps

• After the preliminary scan, we found the following test mode(s) producing the highest emission level and test data of the worst case was recorded.

Mode: 1.

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Data Sample:

Freq. MHz	Read Level dBuV	Factor dB	Level dBuV	Limit dBuV	Over Limit dB	Reading Type (P/Q/A)
X.XX	62.95	0.55	63.50	87	-23.50	Q

Freq. = Emission frequency in MHz

Read Level = Uncorrected Analyzer/Receiver reading

Factor = Insertion loss of ISN + Cable Loss

Level = Read Level + Factor
Limit = Limit stated in standard
Over Limit = Reading in reference to limit

P = Peak Reading

Q = Quasi-peak Reading A = Average Reading

Calculation Formula

Over Limit (dB) = Level (dBuV) – Limit (dBuV)

7.4 TEST PROCEDURE OF RADIATED EMISSION

Procedure of Preliminary Test

- The equipment was set up as per the test configuration to simulate typical usage per the user's manual. When the EUT is a tabletop system, a wooden turntable with a height of 0.8 meters is used which is placed on the ground plane. When the EUT is a floor-standing equipment, it is placed on the ground plane which has a 3-12 mm non-conductive covering to insulate the EUT from the ground plane.
- Support equipment, if needed, was placed as per EN 55022.
- All I/O cables were positioned to simulate typical usage as per EN 55022.
- The EUT received AC power source, 230V/50Hz, from the outlet socket under the turntable. All support equipment received power from another socket under the turntable.
- Mains cables, telephone lines or other connections to auxiliary equipment located outside the
 test are shall drape to the floor, be fitted with ferrite clamps or ferrite tubes placed on the floor
 at the point where the cable reaches the floor and then routed to the place where they leave the
 turntable. No. extension cords shall be used to mains receptacle.
- The antenna was placed at 10 meter away from the EUT as stated in EN 55022. The antenna connected to the Spectrum Analyzer via a cable and at times a pre-amplifier would be used.
- The Analyzer / Receiver quickly scanned from 30MHz to 1000MHz. The EUT test program was started. Emissions were scanned and measured rotating the EUT to 360 degrees and positioning the antenna 1 to 4 meters above the ground plane, in both the vertical and the horizontal polarization, to maximize the emission reading level.

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• The test mode(s) described in Item 3.2 were scanned during the preliminary test:

- After the preliminary scan, we found the test mode described in Item 3.2 producing the highest emission level.
- The EUT and cable configuration, antenna position, polarization and turntable position of the above highest emission level were recorded for the final test.

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Procedure of Final Test

- EUT and support equipment were set up on the turntable as per the configuration with highest emission level in the preliminary test.
- The Analyzer / Receiver scanned from 30MHz to 1000MHz. Emissions were scanned and measured rotating the EUT to 360 degrees, varying cable placement and positioning the antenna 1 to 4 meters above the ground plane, in both the vertical and the horizontal polarization, to maximize the emission reading level.
- Recorded at least the six highest emissions. Emission frequency, amplitude, antenna position, polarization and turntable position were recorded into a computer in which correction factors were used to calculate the emission level and compare reading to the applicable limit and only Q.P. reading is presented.
- The test data of the worst-case condition(s) was recorded.

Data Sample:

Free MH		Amptd dBuV/m	Margin dB	Limit dBuV/m	Reading dBuV	Factor dB/m	Reading Type (P/Q/A)	Pol. (H/V)
x.x	X	26.2	-13.8	40	14	12.2	Q	Н

Freq. = Emission frequency in MHz

Reading = Uncorrected Analyzer/Receiver reading

Factor = Antenna Factor + Cable Loss + Attenuator (3/6/10dB) – Amplifier Gain

Amptd = Uncorrected Analyzer/Receiver reading + Factor

Limit = Limit stated in standard

Margin = Reading in reference to limit

P = Peak Reading

Q = Quasi-peak Reading A = Average Reading

H = Antenna Polarization: Horizontal V = Antenna Polarization: Vertical

Calculation Formula

Margin (dB) = Amptd (dBuV/m) – Limit (dBuV/m)

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7.5 TEST RESULTS

Line Conducted Emission

Model: PCM-8150 Test Mode: Mode 1

Temperature: 20°C **Humidity:** 60% RH

Test Results: Passed **Tested by:** Mark Hsu

(The chart below shows the highest readings taken from the final data, see Appendix III for details.)

	Six Highest Conducted Emission Readings							
Frequency Range Investigated				150 kHz to 30 MHz				
Freq (MHz)	Read Level (dBuV)	Factor (dB/m)	Level (dBuV/m)	Limit Line (dBuV/m)	Over Limit (dB)	Reading Type (P/Q/A)	Pol. (H/V)	
0.214	51.51	0.11	51.62	79.00	-27.38	P	L1	
0.317	51.05	0.12	51.17	79.00	-27.83	P	L1	
0.426	52.33	0.12	52.45	79.00	-26.55	P	L1	
0.214	48.93	0.11	49.04	79.00	-29.96	P	L2	
0.317	51.59	0.12	51.71	79.00	-27.29	P	L2	
0.421	51.83	0.12	51.95	79.00	-27.05	P	L2	

NOTE: The emission level was or more than 2dB below the Average limit, so no re-check anymore.

Common Mode Conducted Emission

Model: PCM-8150 **Test Mode:** Mode 1

Six Highest Conducted Emission Readings								
Frequ	Frequency Range Investigated				150 kHz to 30 MHz			
	Read	п.		1	Limit	Over	Reading	
Freq	Level	Factor	Le	vel	Line	Limit	Type	
(MHz)	(dBuV)	(dB)	(dB	uV)	(dBuV)	(dB)	(P/Q/A)	
5.898	48.85	10.26	59	.11	87.00	-27.89	P	
12.188	51.67	10.22	61	.89	87.00	-25.11	P	
13.408	52.45	10.23	62	.68	87.00	-24.32	P	
15.552	52.99	10.24	63	.23	87.00	-23.77	P	
16.750	50.95	10.25	61	.20	87.00	-25.80	P	
20.814	49.45	10.28	59	.73	87.00	-27.27	P	

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Radiated Emission

Model: PCM-8150 **Test Mode:** Mode 1

Temperature: 19°C **Humidity:** 70% RH

Test Results: Pass **Tested by:** Mark Hsu

(The chart below shows the highest readings taken from the final data, see Appendix III for details.)

Date of Issue: January 18, 2005

Six Highest Radiated Emission Readings								
Fre	quency Ran	ge Investiga	ated	30 MHz to 1000 MHz at 10m				
Freq (MHz)	Amptd (dBuV/m)	Margin (dB)	Limit (dBuV/m)	Reading (dBuV)	Factor (dB/m)	Reading Type (P/Q/A)	Pol. (H/V)	
36.8700	38.41	-1.59	40.00	47.50	-9.09	Q	V	
55.3000	36.17	-3.83	40.00	51.55	-15.38	P	V	
61.4750	38.07	-1.93	40.00	54.30	-16.23	Q	V	
233.5100	38.59	-8.41	47.00	47.53	-8.94	P	V	
858.1616	37.96	-9.04	47.00	35.00	2.96	P	V	
61.4500	36.17	-3.83	40.00	52.40	-16.23	Q	Н	

NOTE: None.

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8 POWER HARMONICS TEST

Port : AC mains

Basic Standard : EN 61000-3-2 (1995+A1: 1998+A2: 1998)

Limits : CLASS A; CLASS D

Tested by : N/A
Temperature : N/A
Humidity : N/A

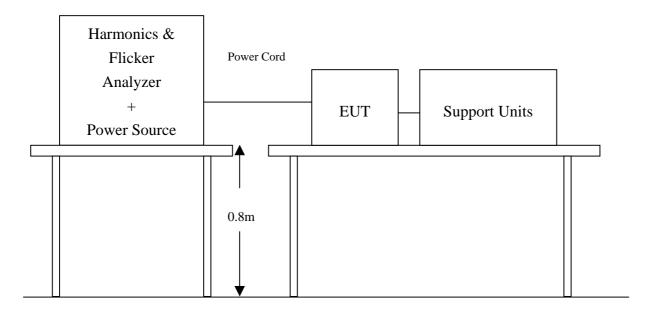
Limit:

Limits for Class A equipment					
Harmonics	Max. permissible				
Order	harmonics current				
n	A				
Od	d harmonics				
3	2.30				
5	1.14				
7	0.77				
9	0.40				
11	0.33				
13	0.21				
15<=n<=39	0.15x15/n				
Eve	en harmonics				
2	1.08				
4	0.43				
6	0.30				
8<=n<=40	0.23x8/n				

Limits for Class D equipment							
Harmonics	Max. permissible harmonics	Max. permissible					
Order	current per watt mA/W	harmonics current					
n		A					
	Odd Harmonics only	1					
3	3.4	2.30					
5	1.9	1.14					
7	1.0	0.77					
9	0.5	0.40					
11	0.35	0.33					
13	0.30	0.21					
15<=n<=39	3.85/n	0.15x15/n					

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Block Diagram of Test Setup:



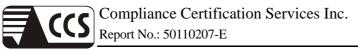
Test Procedure:

- a. The EUT was placed on the top of a wooden table 0.8 meters above the ground and operated to produce the maximum harmonic components under normal operating conditions for each successive harmonic component in turn.
- b. The correspondent test program of test instrument to measure the current harmonics emanated from EUT is chosen. The measure time shall be not less than the time necessary for the EUT to be exercised.

Test Result:

☐ PASS	☐ FAIL
Note: According to clause 7 of EN 61000-3 75W or less, no limits apply. The test result	

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POWER VOLTAGE FLUCTUATION / FLICKER TEST

Port : AC mains

Basic Standard : EN 61000-3-3 (1995 + A1: 2001)

Limits : §5 of EN 61000-3-3

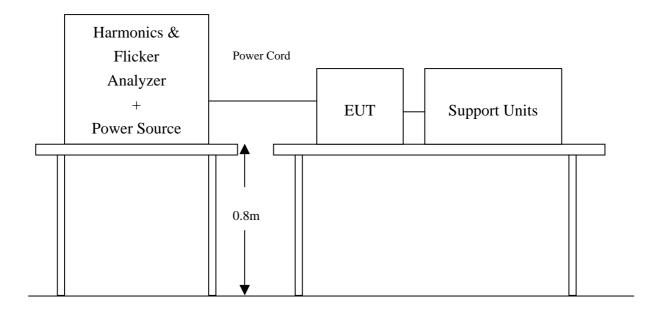
: Marion Yu **Tested by**

: 19°C **Temperature** Humidity : 51%

Limit:

TEST ITEM	LIMIT	REMARK	
P_{st}	1.0	P _{st} means short-term flicker indicator.	
P_{lt}	P _{lt} 0.65 P _{lt} means long-term		
T _{dt} (ms)	500	T_{dt} means maximum time that dt exceeds 3.3 %.	
d _{max} (%) 4%		d_{max} means maximum relative voltage change.	
dc (%) 3.3%		dc means relative steady-state voltage change	

Block Diagram of Test Setup:



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Test Procedure:

- a. The EUT was placed on the top of a wooden table 0.8 meters above the ground and operated to produce the most unfavorable sequence of voltage changes under normal operating conditions.
- b. During the flick measurement, the measure time shall include that part of whole operation cycle in which the EUT produce the most unfavorable sequence of voltage changes. The observation period for short-term flicker indicator is 10 minutes and the observation period for long-term flicker indicator is 2 hours.

Date of Issue: January 18, 2005

Test Result: (See Appendix II for details)

TEST PARAMETER	MEASUREMENT VALUE	LIMIT	RESULT
P_{st}	0.001	1.0	Pass
P_{lt}	0.001	0.65	Pass
T _{dt} (ms)	0.0	500	Pass
d _{max} (%)	0.00	4%	Pass
dc (%)	0.00	3.3%	Pass

Observation: None.

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10 ELECTROSTATIC DISCHARGE (ESD) IMMUNITY TEST

Port : Enclosure

Basic Standard: IEC/EN 61000-4-2

Test Level : $\pm 8 \text{ kV (Air Discharge)}$

 \pm 4 kV (Contact Discharge)

± 4 kV (Indirect Discharge)

Performance Criterion: B (Standard Required)

Tested by : Marion Yu

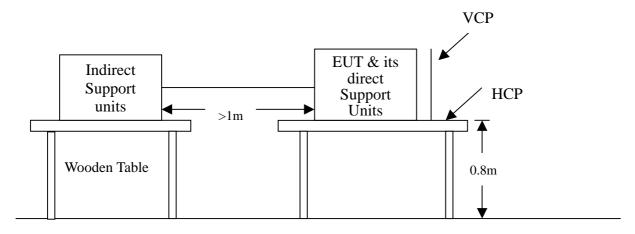
Temperature : 19°C

Humidity : 51%

Pressure : 1001mbar

Block Diagram of Test Setup:

(The 470 k ohm resistors are installed per standard requirement.)



Ground Reference Plane

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Test Procedure:

- 1. The EUT was located 0.1 m minimum from all sides of the HCP.
- 2. The indirect support units were located 1 m minimum away from the EUT, but direct support unit was/were located at same location as EUT on the HCP and keep at a distance of 10 cm with EUT.

Date of Issue: January 18, 2005

- 3. As per the requirement of EN 55024; applying direct contact discharge at the sides other than front of EUT at minimum 50 discharges (25 positive and 25 negative) if applicable, can't be applied direct contact discharge side of EUT then the indirect discharge shall be applied. One of the test points shall be subjected to at least 50 indirect discharge (contact) to the front edge of horizontal coupling plane.
- 4. Other parts of EUT where it is not possible to perform contact discharge then selecting appropriate points of EUT for air discharge, a minimum of 10 single air discharges shall be applied.
- 5. The application of ESD to the contact of open connectors is not required.
- 6. The EUT direct connection units also need to be applied ESD at the port of EUT cable connected.
- 7. Putting a mark on EUT to show tested points. The following test condition was followed during the tests.

Note: As per IEC/EN 61000-4-2, two 470k bleed resistors cable is connected between the EUT and HCP during the test applicable for power ungrounded or battery operating unit only.

The electrostatic discharges were applied as follows:

Amount of discharge	Voltage	Coupling	Result (Pass/Fail)
Mini 10 /Point	$\pm~8~kV$	Air Discharge	Pass
Mini 25 /Point	$\pm 4 \text{ kV}$	Contact Discharge	Pass
Mini 25 /Point	$\pm 4 \text{ kV}$	Indirect Discharge HCP (Front)	Pass
Mini 25 /Point	$\pm 4 \text{ kV}$	Indirect Discharge VCP (Right)	Pass
Mini 25 /Point	$\pm 4 \text{ kV}$	Indirect Discharge VCP (Left)	Pass
Mini 25 /Point	$\pm 4 \text{ kV}$	Indirect Discharge VCP (Back)	Pass

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Performance & Result:

	Criterion A:	The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.
	Criterion B:	The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
	Criterion C:	Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.
Ol	oservation:	No function degraded during the tests.

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11 RADIATED ELECTROMAGNETIC FIELD IMMUNITY TEST

Port : Enclosure

Basic Standard: IEC/EN 61000-4-3

Requirements : 3 V/m / with 80% AM. 1kHz Modulation.

Performance Criterion: A (Standard Required)

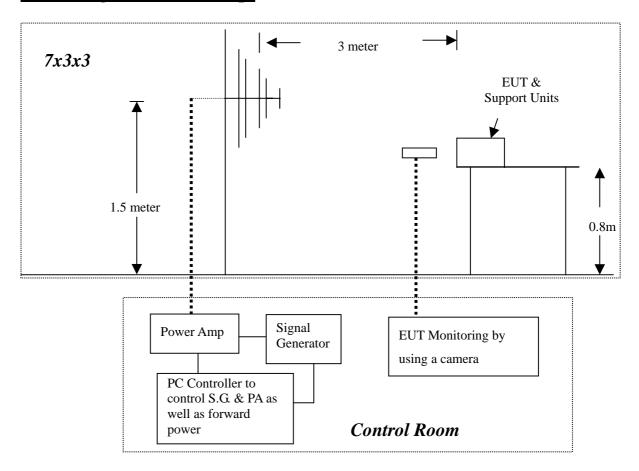
Tested by : Marion Yu

Temperature : 19°C

Humidity : 51%

Pressure : 1001mbar

Block Diagram of Test Setup:



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Test Procedure:

1. The EUT and support units were located at the edge of supporting table keep 3 meter away from transmitting antenna, it just the calibrated square area of field uniformity.

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- 2. Adjusting the cables to be exposed to the electromagnetic filed as possible.
- 3. Performing a Radiated Emission Scan in range of 30 to 1000 MHz prior to do RS test and records the more higher emission frequencies for the reference of RS test, due to antenna effectiveness.
- 4. Adjusting the monitoring camera to monitor the "H" message as clear as possible.
- 5. Setting the testing parameters of RS test software per IEC 61000-4-3.
- 6. Referring to the tested data of step 3 to performing the RS test from 80 to 1000 MHz.
- 7. Recording the test result in following table.
- 8. Changing the EUT to the other side and repeat step 3 to 6, until 4 sides of EUT were verified.

IEC 61000-4-3 Final test conditions:

Test level : 3V/m

Steps : 1 % of fundamental

Dwell Time: 3 sec

Range (MHz)	Field	Modulation	Polarity	Position (°)	Result (Pass/Fail)
80-1000	3V/m	Yes	Н	Front	Pass
80-1000	3V/m	Yes	V	Front	Pass
80-1000	3V/m	Yes	Н	Right	Pass
80-1000	3V/m	Yes	V	Right	Pass
80-1000	3V/m	Yes	Н	Back	Pass
80-1000	3V/m	Yes	V	Back	Pass
80-1000	3V/m	Yes	Н	Left	Pass
80-1000	3V/m	Yes	V	Left	Pass

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Performance & Result:

	Criterion A:	The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.			
	Criterion B: The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.				
	Criterion C:	Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.			
Oł	oservation:	No function degraded during the tests.			

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12 FAST TRANSIENTS/BURST IMMUNITY TEST

Port : On Power Supply Lines and Data Line

Basic Standard: IEC/EN 61000-4-4

Requirements : $\pm 1 \text{ kV}$ for Power Supply Line

 \pm 0.5 kV to Data Line

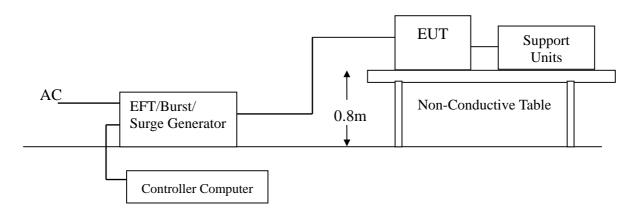
Performance Criteria: B (Standard Required)

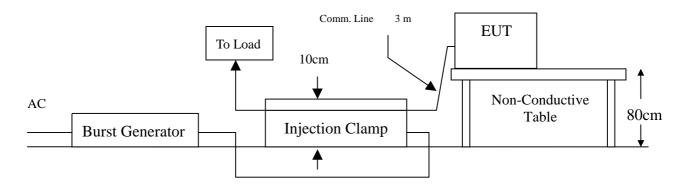
Tested by : Marion Yu

Temperature : 19°C **Humidity** : 51%

Pressure : 1001mbar

Block Diagram of Test Setup:





Test Procedure:

- 1. The EUT and support units were located on a wooden table 0.8 m away from ground reference plane.
- 2. A 1.0 meter long power cord was attached to EUT during the test.
- 3. The length of communication cable between communication port and clamp was keeping within 1 meter.
- 4. Injected test voltage to the EUT ports from minimum to standard request or client request.
- 5. Recorded the test result as shown in following table.

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Test conditions:

Impulse Frequency: 5kHz
Tr/Th: 5/50ns
Burst Duration: 15ms
Burst Period: 3Hz

Inject Line	Voltage kV	Inject Method	Result (Pass/Fail)
L	± 1	Direct	Pass
N	± 1	Direct	Pass
PE	± 1	Direct	Pass
L+N	± 1	Direct	Pass
L + PE	± 1	Direct	Pass
N + PE	± 1	Direct	Pass
L + N + PE	± 1	Direct	Pass
RJ45	±0.5	Clamp	Pass

Performance & Result:

Criterion A:	The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.				
Criterion B:	on B: The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.				
Criterion C: Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.					
Observation:	No function degraded during the tests.				

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13 SURGE IMMUNITY TEST

Port : Power Cord

Basic Standard : IEC/EN 61000-4-5
Requirements : ± 1 kV (Line to Line)

± 2 kV (Line to Ground)

Date of Issue: January 18, 2005

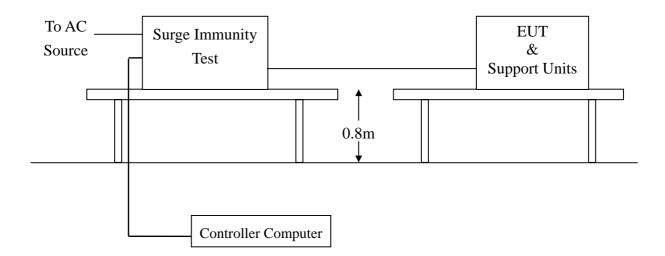
Performance Criteria: B (Standard Required)

Tested by : Marion Yu

Temperature : 19°C **Humidity** : 51%

Pressure : 1001mbar

Block Diagram of Test Setup:



Test Procedure:

- 1. The EUT and support units were located on a wooden table 0.8 m away from ground floor.
- 2. Injected test voltage to the EUT ports from minimum to standard request or client request.
- 3. Recorded the test result as shown in following table.

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Test conditions:

Voltage Waveform : 1.2/50 us Current Waveform : 8/20 us

Polarity : Positive/Negative Phase angle : 0°, 90°, 270°

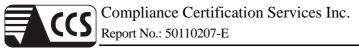
Number of Test : 5

Coupling Line	Voltage (kV)	Polarity	Coupling Method	Result (Pass/Fail)
L1-L2	1	Positive	Capacitive	Pass
L1-PE	2	Positive	Capacitive	Pass
L2-PE	2	Positive	Capacitive	Pass
L1-L2	1	Negative	Capacitive	Pass
L1-PE	2	Negative	Capacitive	Pass
L2-PE	2	Negative	Capacitive	Pass

Performance & Result:

	Criterion A:	The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.
	Criterion B:	The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
		Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.
(Observation	• Where normal functioning of Lan can't be achieved because of the impact of CDN on the EUT, no test be required

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14 CONDUCTED DISTRBANCE/INDUCED RADIO-FREQUENCY FIELD IMMUNITY TEST

Port : AC Port and Line Cable

Basic Standard : IEC/EN 61000-4-6

Requirements : 3 V, with 80% AM. 1kHz Modulation.

Injection Method : CDN-M3 for Power Cord

CDN-T4 for RJ45 Cable

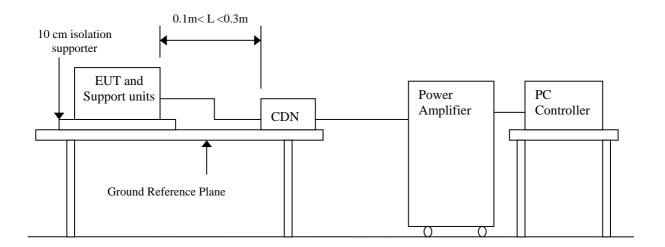
Performance Criterion: A (Standard Required)

Tested by : Marion Yu

: 19°C **Temperature** Humidity : 51%

Pressure : 1001mbar

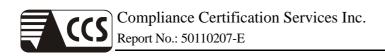
Block Diagram of Test Setup:



Test Procedure:

- The EUT and support units were located at a ground reference plane with the interposition of a 0.1 m thickness insulating support and the CDN was located on GRP directly.
- 2. Set the testing parameters of CS test software as per IEC/EN 61000-4-6.
- Recorded the test result in following table.

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Test conditions:

Frequency Range : 0.15MHz-80MHz
Frequency Step : 1% of fundamental

Dwell Time : 3 sec

Range (MHz)	Field	Modulation	Result (Pass/Fail)
0.15-80	3V	Yes	Pass

Date of Issue: January 18, 2005

Performance & Result: Criterion A: The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. **Criterion B:** The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed. **Criterion C:** Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls. |X PASS **FAIL Observation:** No function degraded during the tests.

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15 POWER FREQUENCY MAGNETIC FIELD IMMUNITY TEST

Port : Enclosure

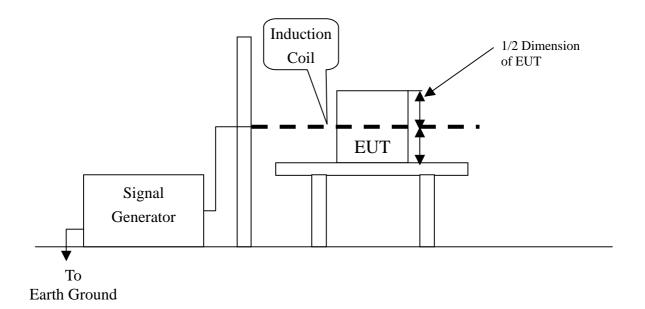
Basic Standard: IEC/EN 61000-4-8

Requirements : 1 A/m

Performance Criterion: A (Standard Required)

Tested by : N/A
Temperature : N/A
Humidity : N/A
Pressure : N/A

Block Diagram of Test Setup:



Test Procedure:

- 1. The EUT and support units were located on Ground Reference Plane with the interposition of a 0.1 m thickness insulation support.
- 2. Put the induction coil on horizontal direction. (X direction)
- 3. Recorded the test result as shown in following table.
- 4. Rotated the induction coil by 90° (Y direction) then repeat step 3.
- 5. Rotated the induction coil by 90° (Z direction) then repeat step 3.

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Test conditions:

Field Strength: 1A/m Power Freq.: 50Hz Orientation: X, Y, Z

Orientation	Field	Result (Pass/Fail)	Remark

Date of Issue: January 18, 2005

Performance &	& Result:		
Criterion A:	The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.		
Criterion B:	The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.		
Criterion C: Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.			
	PASS FAIL		
Observation:	The EUT is not containing any component that is susceptible to a 50 Hz or 60 Hz magnetic field. Therefore, this requirement is not applicable to the EUT.		

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16 VOLTAGE DIPS / SHORT INTERRUPTIONS

Port : AC mains

Basic Standard: IEC/EN 61000-4-11

Requirement: PHASE ANGLE 0, 45, 90, 135, 180, 225, 270, 315 degrees

Date of Issue: January 18, 2005

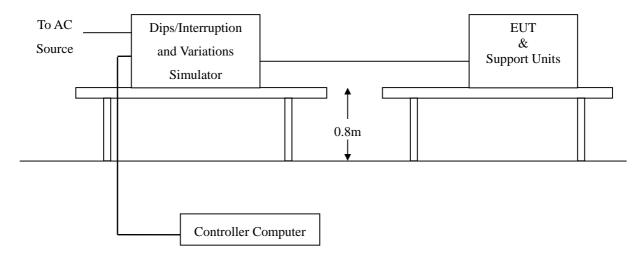
Test Interval : Min. 10 sec. **Tested by** : Marion Yu **Temperature** : 19°C

Humidity : 51% Pressure : 1001mbar

Voltage	Test Level % U _T	Reduction (%)	Duration (periods)	Performance Criterion
Voltage Dips	<5	>95	0.5	В
	70	30	25	C

Voltage Interceptions	Test Level % U _T	Reduction (%)	Duration (periods)	Performance Criterion
Interceptions	<5	>95	250	С

Block Diagram of Test Setup:



Test Procedure:

- 1. The EUT and support units were located on a wooden table, 0.8 m away from ground floor.
- 2. Set the parameter of tests and then Performed the test software of test simulator.
- 3. Changed Condition to occur at 0 degree crossover point of the voltage waveform.
- 4. Recorded the test result in test record form.

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Test conditions:

The duration with a sequence of three dips/interruptions with interval of 10 sec. minimum (Between each test event)

Date of Issue: January 18, 2005

Voltage Dips:

Test Level % U _T	Reduction (%)	Duration (periods)	Observation	Meet Performance Criterion
0	100	0.5	Normal	A
70	30	25	Normal	A

Voltage Interruptions:

Test Level % U _T	Reduction (%)	Duration (periods)	Observation	Meet Performance Criterion
0	100	250	EUT shut down, but can be auto recovered as the events disappear.	С

Note: "Normal" means no any functions degrade during and after the test.

Performance & Result:

Criterion A: The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of

performance.

Criterion B: The apparatus continues to operate as intended after the test. No

degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of

performance is however allowed.

Criterion C: Temporary loss of function is allowed, provided the functions self

recoverable or can be restored by the operation of controls.

	☐ FAIL					
Observation: No function degraded during the tests.						

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APPENDIX I - PHOTOGRAPHS OF TEST SETUP

LINE CONDUCTED EMISSION TEST (EN 55022)

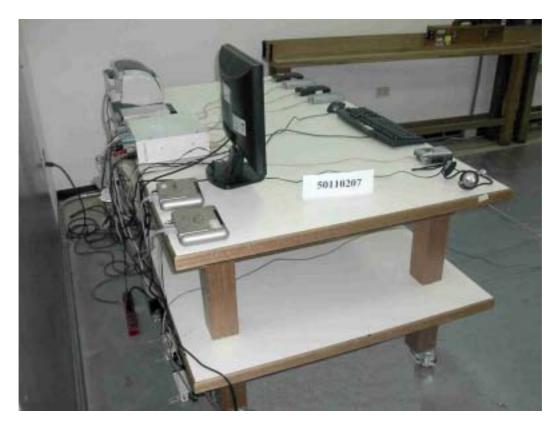




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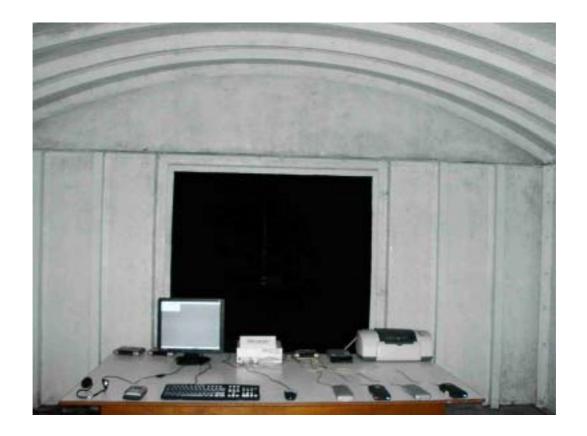
COMMON MODE CONDUCTED EMISSION TEST





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RADIATED EMISSION TEST





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POWER HARMONIC & VOLTAGE FLUCTUATION / FLICKER TEST





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ELECTROSTATIC DISCHARGE TEST



RADIATED ELECTROMAGNETIC FIELD TEST



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FAST TRANSIENTS/BURST TEST



FAST TRANSIENTS/BURST TEST (IEC 61000-4-4 FOR I/O)



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SURGE IMMUNITY TEST



CONDUCTED DISTURBANCE, INDUCED BY RADIO-FREQUENCY FIELDS TEST



Page 44 Rev. 00

CONDUCTED DISTURBANCE, INDUCED BY RADIO-FREQUENCY FIELDS TEST (IEC 61000-4-6 FOR I/O)



VOLTAGE DIPS / INTERRUPTION TEST



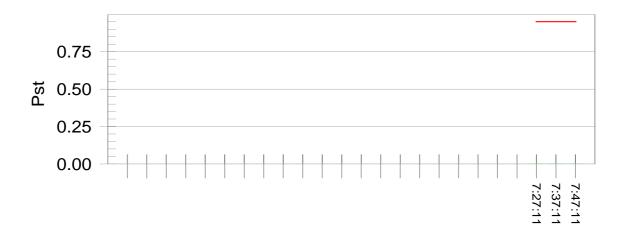
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APPENDIX II - TEST RESULT OF EN 61000-3-3

Test Result: Pass Status: Test Completed

Pst_i and limit line European Limits



Time is too short for Plt plot

Parameter values recorded during the test:

Vrms at the end of test (Volt):	229.77			
Highest dt (%):	0.00	Test limit (%):	3.14	Pass
Time(mS) > dt:	0.0	Test limit (mS):	500.0	Pass
Highest dc (%):	0.00	Test limit (%):	3.14	Pass
Highest dmax (%):	0.00	Test limit (%):	3.80	Pass
Highest Pst (10 min. period):	0.001	Test limit:	0.950	Pass
Highest Plt (2 hr. period):	0.001	Test limit:	0.617	Pass

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APPENDIX III - TEST RESULT OF FINAL DATAS

Conducted Emission Plot

Date of Issue: January 18, 2005

Radiated Emission Data

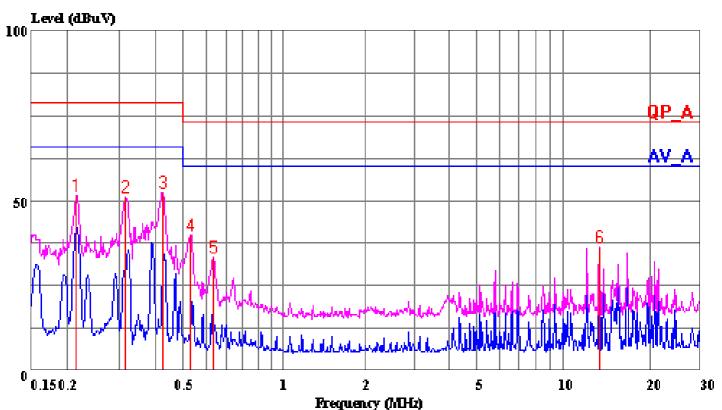
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No. 199, Chung Sheng Road, Hsin Tien City, Taipei, Taiwan, R.O.C.

Tel:02-2217-0894 Fax:02-2217-1029

Data#: 25 File#: 50110207C.EMI Date: 2005-01-10 Time: 23:10:56



(Conduction A)

Trace: 24 23 Ref Trace:

Condition: LINE

Report No. : 50110207 Test Engr. : MARK HSU

Company : AAEON Technology Inc.

EUT : PCM-8150

Test Config : EUT / ALL PERIPHERALS

Type of Test: EN 55022 CLASS A Mode of Op. : NORMAL MODE

Page: 1

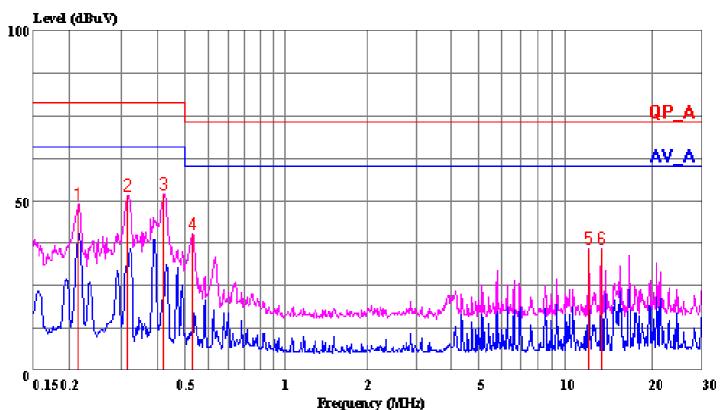
	Freq	Read Level	Factor	Level	Limit Line		Remark
	MHz	dBuV	dB	dBuV	dBuV	dB	
1 2	0.214 0.317	51.51 51.05		51.62 51.17			
3	0.426	52.33	0.12			-26.55	
4	0.527	39.89	0.12	40.01	73.00	-32.99	Peak
5	0.637	33.25	0.13	33.38	73.00	-39.62	Peak
6	13.408	35.79	0.60	36.39	73.00	-36.61	Peak



No. 199, Chung Sheng Road, Hsin Tien City, Taipei, Taiwan, R.O.C.

Tel:02-2217-0894 Fax:02-2217-1029

Data#: 28 File#: 50110207C.EMI Date: 2005-01-10 Time: 23:14:41



(Conduction A)

Trace: 27 26 Ref Trace:

Condition: NEUTRAL
Report No. : 50110207
Test Engr. : MARK HSU

Company : AAEON Technology Inc.

EUT : PCM-8150

Test Config : EUT / ALL PERIPHERALS

Type of Test: EN 55022 CLASS A Mode of Op.: NORMAL MODE

Page: 1

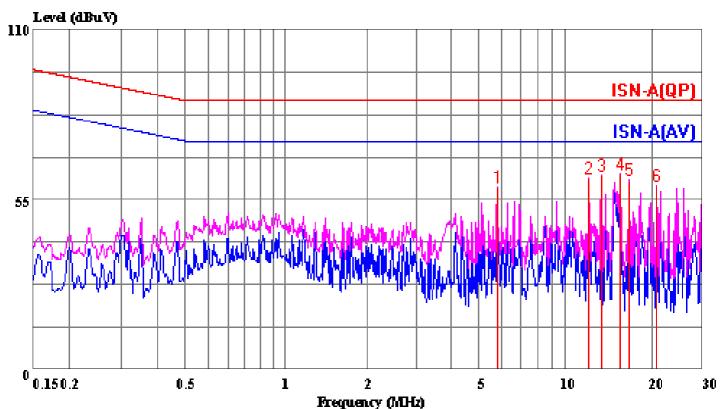
	Freq	Read Level	Factor	Level	Limit Line	Over Limit	Remark
	MHz	dBuV	dB	dBuV	dBuV	dB	
1 2	0.214 0.317	48.93 51.59		49.04 51.71		-29.96 -27.29	
3	0.421	51.83		51.95		-27.05	
4	0.527	39.93	0.12	40.05	73.00	-32.95	Peak
5	12.188	35.31	0.47	35.78	73.00	-37.22	Peak
6	13.408	35.51	0.50	36.01	73.00	-36.99	Peak



No. 199, Chung Sheng Road, Hsin Tien City, Taipei, Taiwan, R.O.C.

Tel:02-2217-0894 Fax:02-2217-1029

Data#: 22 File#: 50110207C.EMI Date: 2005-01-10 Time: 23:05:16



(Conduction A)

Trace: 21 20 Ref Trace:

Condition: COMMON MODE Report No. : 50110207 Test Engr. : MARK HSU

Company : AAEON Technology Inc.

EUT : PCM-8150

Test Config : EUT / ALL PERIPHERALS Type of Test: EN 55022 CLASS A Mode of Op. : 100Mbps / WORST

Page: 1

		Read			Limit	Over	
	Freq	Level	Factor	Level	Line	Limit	Remark
	MHz	dBuV	dB	dBuV	dBuV	dB	
1	5.898	48.85	10.26	59.11	87.00	-27.89	Peak
2	12.188	51.67	10.22	61.89	87.00	-25.11	Peak
3	13.408	52.45	10.23	62.68	87.00	-24.32	Peak
4	15.552	52.99	10.24	63.23	87.00	-23.77	Peak
5	16.750	50.95	10.25	61.20	87.00	-25.80	Peak
6	20.814	49.45	10.28	59.73	87.00	-27.27	Peak

Site J

Custom Name: AAEON Technology Inc.

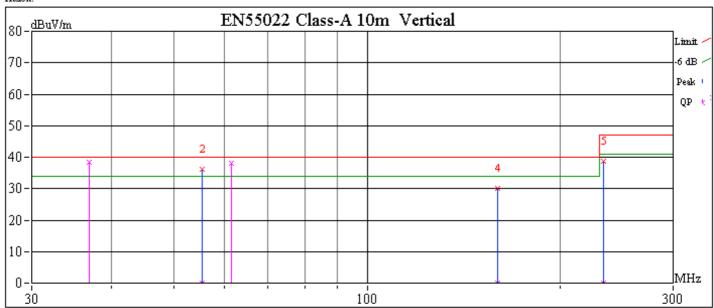
Model Name: PCM-8150

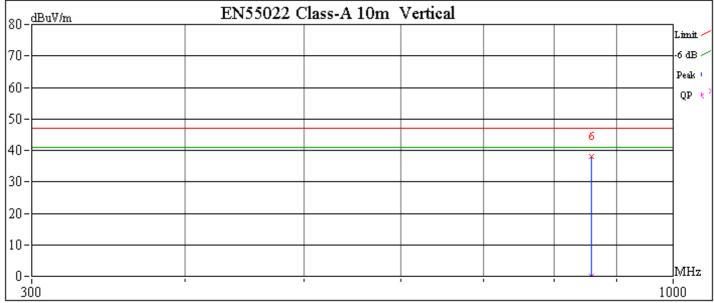
Test Mode: NORMAL MODE

Project No.: 50110207 Engineer Name: MARK HSU

Date: 2005-01-10

Index:





	Freq(MHz)	Peak(dBuV/m)	QP(dBuV/m)	Margin(dB)	Limit(dBuV/m)	Reading(dBuV)	Factor(dB)	Height	Degree	Comment
1	36.8700	-9.09	38.41	-1.59	40.00	47.50	-9.09	100	0	
2	55.3000	36.17		-3.83	40.00	51.55	-15.38	100	0	
3	61.4750	-16.23	38.07	-1.93	40.00	54.30	-16.23	100	0	
4	159.7200	30.01		-9.99	40.00	40.89	-10.88	100	0	
5	233.5100	38.59		-8.41	47.00	47.53	-8.94	100	0	
6	858.1616	37.96		-9.04	47.00	35.00	2.96	100	0	

Site J

Custom Name: AAEON Technology Inc.

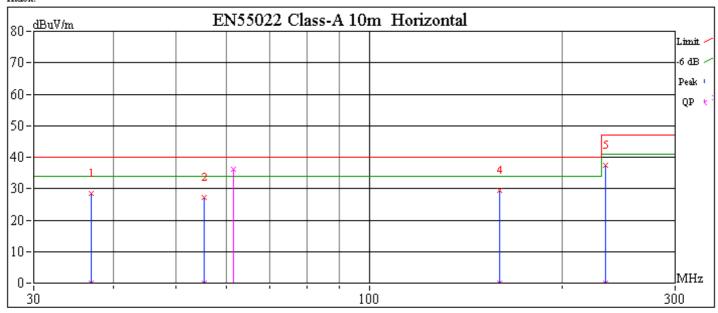
Model Name: PCM-8150

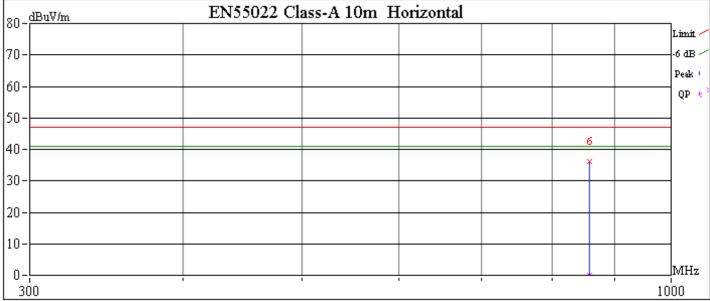
Test Mode: NORMAL MODE

Project No.: 50110207 Engineer Name: MARK HSU

Date: 2005-01-10

Index:





	Freq(MHz)	Peak(dBuV/m)	QP(dBuV/m)	Margin(dB)	Limit(dBuV/m)	Reading(dBuV)	Factor(dB)	Height	Degree	Comment
1	36.8710	28.37		-11.63	40.00	37.46	-9.09	100	0	
2	55.2700	27.14		-12.86	40.00	42.51	-15.37	100	0	
3	61.4500	-16.23	36.17	-3.83	40.00	52.40	-16.23	100	0	
4	159.9500	29.38		-10.62	40.00	40.27	-10.89	100	0	
5	233.4900	37.36		-9.64	47.00	46.30	-8.94	100	0	
6	858.1500	36.06		-10.94	47.00	33.10	2.96	100	0	